

**Search Notes**

Application/Control No.

10/644,243

Examiner

Patrick J. Lee

Applicant(s)/Patent under  
Reexamination

CLARK ET AL.

Art Unit

2878

**SEARCHED**

Class	Subclass	Date	Examiner
250	234-236, 216, 201.5, 559.11	10/31/2005	PL
250	559.22	10/31/2005	PL
250	559.4	10/31/2005	PL
250	559.45	10/31/2005	PL
356	237.2	10/31/2005	PL
369	44.14	10/31/2005	PL
369	44.23	10/31/2005	PL
369	47.1	10/31/2005	PL
369	112.01	10/31/2005	PL
369	275.1	10/31/2005	PL
359	237-324	11/14/2005	PL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
250	234	10/31/2005	PL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted w/ S. Allen	8/4/2005	PL
East (see attached)	8/8/2005	PL
East (see attached)	8/11/2005	PL
East (see attached)	8/16/2005	PL
East (see attached)	10/31/2005	PL
East (see attached)	11/14/2005	PL